EMI TEST REPORT

Test Report No. : 28IE0116-HO-02-B

Applicant	:	**silex technology, Inc.**
Type of Equipment	:	**MiniPCI Wireless LAN Board**
Model No.	:	**SX-10WAN**
FCC ID	:	**N6C-SX10WAN**
Test regulation	:	**FCC Part 15 Subpart E: 2009** **Section 15.407(DFS test only)**
Test Result	:	**Complied**

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test : April 7, 2009

Tested by : T. Hatakeda
Takahiro Hatakeda
EMC Services

Approved by : T. Maeno
Tetsuo Maeno
Site Manager of EMC Services

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UL Japan, Inc.
Head Office EMC Lab.
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116
Facsimile : +81 596 24 8124

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SECTION 1: Customer information

Company Name	:	silex technology, Inc.
Address	:	2-3-1 Hikaridai, Seika-cho, Kyoto 619-0237, Japan
Telephone Number	:	+81-774-98-3878
Facsimile Number	:	+81-774-98-3758
Contact Person	:	Toshiro Kometani

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	MiniPCI Wireless LAN Board
Model No.	:	SX-10WAN
Serial No.	:	008092011315
Rating	:	DC3.3V
Receipt Date of Sample	:	November 6, 2008
Country of Mass-production	:	Japan
Condition of EUT	:	Production prototype
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model No: SX-10WAN (referred to as the EUT in this report) is the MiniPCI Wireless LAN Board.
SX-10WAN is a MiniPCI TypeIII-A Wireless LAN module of the DualBand IEEE802.11a/b/g/n standard equivalent which supported EU RoHS.

Equipment Type	:	Transceiver
Clock frequency	:	40MHz
Method of Frequency Generation	:	Synthesizer
Operating voltage(Power Supply)	:	DC3.3V
Operating voltage (inner)	:	DC1.2V, DC1.8V
Maximum Antenna Gain	:	1.5dBi@2.4GHz, 2.1dBi@5.825GHz

	IEEE802.11b	**IEEE802.11g**	**IEEE802.11a**	**IEEE802.11n (20HT)**	**IEEE802.11n (40HT)**
Frequency of operation	2412-2462MHz		5180 - 5320MHz 5745 - 5825MHz	2412 - 2462MHz 5180 - 5320MHz 5745 - 5825MHz	2422 - 2452MHz 5190 - 5310MHz 5755 - 5795MHz
Type of modulation	DSSS (CCK, DQPSK, DBPSK)	OFDM-CCK (64QAM, 16QAM, QPSK, BPSK)	OFDM (64QAM, 16QAM, QPSK, BPSK)		
Channel spacing	5MHz		20MHz	2.4GHz band 5MHz 5GHz band 20MHz	2.4GHz band 5MHz 5GHz band 40MHz
Antenna type	Sleeve antenna (Omni-Directional)				
Antenna Connector type (on Module)	U.FL				
Antenna Connector type (Antenna itself)	Reverse SMA				

SECTION 3: Scope of Report

The EUT has the channels from 5180 to 5320MHz.
This report only covers DFS requirement subject to 5250-5350MHz bands, as specified by the following referenced procedures.

SECTION 4: Test specification, procedures & results

4.1 Test Specification

Test Specification	:	FCC Part15 Subpart E: 2009, final revised on February 27, 2009
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart E Unlicensed National Information Infrastructure Devices Section 15.407 General technical requirements

* The revision on February 27, 2009 does not influence the test specification applied to the EUT.

Test Specification	:	FCC 06-96 APPENDIX
Title	:	COMPLIANCE MEASUREMENT PROCEDURES FOR UNLICENSED- NATIONAL INFORMATION INFRASTRUCTURE DEVICES OPERATING IN THE 5250-5350 MHz AND 5470-5725MHz BANDS INCORPORATING DYNAMIC FREQUENCY SELECTION

FCC 15.31 (e)
The RF Module has own regulator.
The RF Module is constantly provided voltage through own regulator regardless of input voltage (DC3.3V).
Therefore, this EUT complies with the requirement.

FCC Part 15.203/212 Antenna requirement
The EUT has a unique antenna connector (U.FL on the Module and Reverse SMA for Antenna itself).
Therefore the equipment complies with the requirement of 15.203/212.

4.2 Procedures and results

Table 1: Applicability of DFS Requirements

Requirement	Operating Mode Client without Radar Detection	Test Procedures & Limits	Deviation	Results
U-NII Detection Bandwidth	Not required	FCC 06-96 Appendix 7.8.1	N/A	N/A
Initial Channel Availability Check Time	Not required	FCC15.407 (h) FCC 06-96 Appendix 7.8.2.1 RSS-210 A9.4	N/A	N/A
Radar Burst at the Beginning of the Channel Availability Check Time	Not required	FCC15.407 (h) FCC 06-96 Appendix 7.8.2.2 RSS-210 A9.4	N/A	N/A
Radar Burst at the End of the Channel Availability Check Time	Not required	FCC15.407 (h) FCC 06-96 Appendix 7.8.2.3 RSS-210 A9.4	N/A	N/A
In-Service Monitoring for Channel Move Time, Channel Closing Transmission Time	Yes	FCC15.407 (h) FCC 06-96 Appendix 7.8.3 RSS-210 A9.4	N/A	Complied
In-Service Monitoring for Non-Occupancy period	Yes *	FCC15.407 (h) FCC 06-96 Appendix 7.8.3 RSS-210 A9.4	N/A	Complied
Statistical Performance Check	Not required	FCC15.407 (h) FCC 06-96 Appendix 7.8.4	N/A	N/A

*Although this test was not required in FCC 06-96, it was performed as additional test.

Table 2: DFS Detection Thresholds for Master Devices and Client Devices With Radar

Maximum Transmit Power	Value (See Notes 1 and 2)
≥ 200 milliwatt	-64 dBm
< 200 milliwatt	-62 dBm
Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna. Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response.	

Table 3 DFS Response Requirement Values

Parameter	Value
Non-occupancy period	Minimum 30 minutes
Channel Availability Check Time	60 seconds
Channel Move Time	10 seconds See Note 1
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2
U-NII Detection Bandwidth	Minimum 80% of the U-NII 99% transmission power bandwidth See Note 3

Note 1: The instant that the Channel Move Time and the Channel Closing Transmission Time begins is as follows:

- For the Short Pulse Radar Test Signals this instant is the end of the *Burst*.
- For the Frequency Hopping radar Test Signal, this instant is the end of the last radar *Burst* generated
- For the Long Pulse Radar Test Signal this instant is the end of the 12 second period defining the *Radar Waveform*.

Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required to facilitate a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signal will not count quiet periods in between transmissions.

Note 3: During the U-NII Detection Bandwidth detection test, radar type 1 is used and for each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.

Table 4 Short Pulse Radar Test Waveform

Radar Type	Pulse Width (µsec)	PRI (µsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
1	1	1428	18	60%	30
2	1-5	150-230	23-29	60%	30
3	6-10	200-500	16-18	60%	30
4	11-20	200-500	12-16	60%	30
Aggregate (Radar Types 1-4)				80%	120

Table 5 Long Pulse Radar Test Waveform

Radar Type	Pulse Width (µsec)	Chip Width (MHz)	PRI (µsec)	Number of Pulses per *Burst*	Number of *Burst*	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5-20	1000-2000	1-3	8-20	80%	30

Table 6 Frequency Hopping Radar Test Waveform

Radar Type	Pulse Width (µsec)	PRI (µsec)	Pulse per Hop (kHz)	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70%	30

4.3 Test Location

UL Japan, Inc. Head Office EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

4.4 Test set up, Data of DFS test, and Test instruments of DFS

Refer to APPENDIX 1 to 3.

SECTION 5: Operation of E.U.T. during testing

5.1 Operating Modes

The EUT, which is a Client Device without Radar detection capability, operates over the 5260-5320MHz.

The highest power level is 18.33dBm EIRP in the 5260-5320MHz band.
The lowest power level is 15.34dBm EIRP in the 5260-5320MHz band.

Power level(EIRP) of the EUT[dBm]

5250-5350MHz Band*	
Output Power (Min)	Output Power(Max)
15.34	18.33

*Refer to 28IE0116-HO-02-C, FCC Part 15E (FCC 15.407) report for other parts than DFS.

The lowest antenna assembly gain of all available antenna assemblies is 2.10dBi.

The EUT uses three 50-ohm coaxial antenna ports. All antenna ports are connected to the test system via a power divider to perform conducted tests.

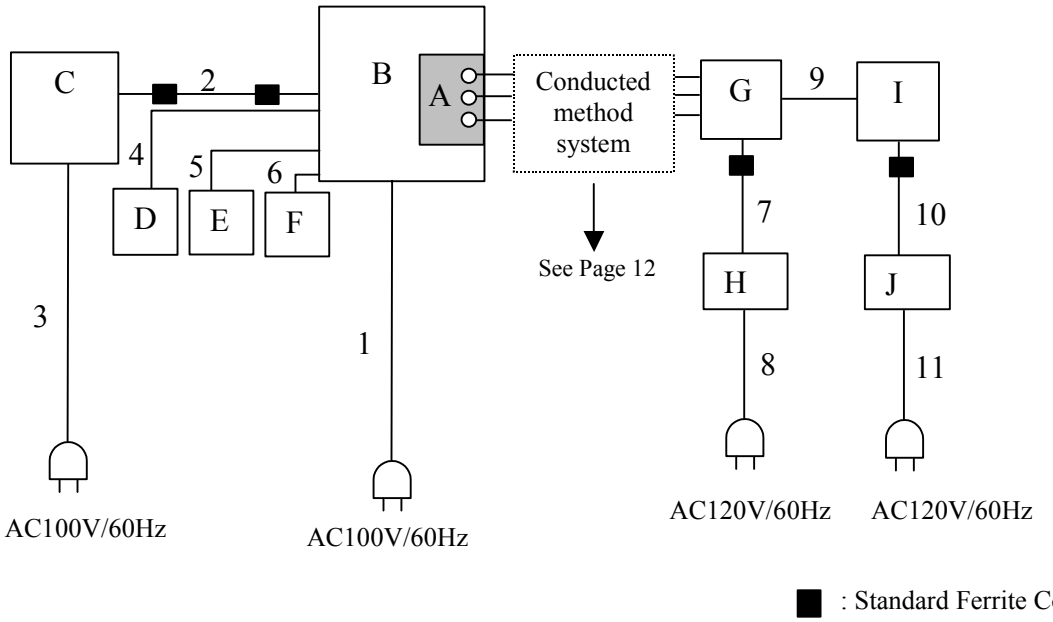
WLAN traffic is generated by streaming the MPEG Test file "6 ½ Magic Hours" from the Master to the Client in full motion video mode using the media player with the V2.61 Codec package.

The EUT utilizes the 802.11n architecture, with a nominal channel bandwidth.

The FCC ID for the Master Device used with EUT for DFS testing is LDK102061.

The rated output power of the Master unit is >200mW(23dBm). Therefore the required interference threshold level is –64 dBm. After correction for antenna gain and procedural adjustments, the required conducted threshold at the antenna port is –64 + 1 + 3.5=-59.5 dBm (threshold level + additional 1dB + antenna gain).

5.2 Configuration and peripherals



Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	MiniPCI Wireless LAN Board	SX-10WAN	008092011315	silex	EUT
B	PC	DIMENSION 2400	CN-0U5399-70821-51L-43WL	DELL	-
C	Monitor	RDT1714VM	6Z104838BJ	MITSUBISHI	-
D	Keyboard	SK-8110	CN-0C6227-71616-51H-OTEH	DELL	-
E	Mouse	M071KC	502072551	DELL	-
F	earphone	-	-	-	-
G	Wireless LAN access point	AIR-AP1252AG-A-K9	FTX122391JU	Cisco Systems	-
H	AC adapter	EADP-45BB	DTH11329086	DELTA ELECTRONICS, INC.	-
I	Note PC	PP04X	42432660429	DELL	-
J	AC adapter	SA90PSO-00	CN-0YD644-69802-6A7-00UL	DELL	-

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	AC Cable	1.5	Unshielded	Unshielded
2	Signal Cable	1.2	Unshielded	Unshielded
3	AC Cable	1.5	Unshielded	Unshielded
4	Signal Cable	1.8	Unshielded	Unshielded
5	Signal Cable	1.8	Unshielded	Unshielded
6	Audio Cable	0.5	Unshielded	Unshielded
7	DC Cable	1.8	Unshielded	Unshielded
8	AC Cable	2.0	Unshielded	Unshielded
9	LAN Cable	3.0	Unshielded	Unshielded
10	DC Cable	1.8	Unshielded	Unshielded
11	AC Cable	1.0	Unshielded	Unshielded

5.3 Test and Measurement System

SYSTEM OVERVIEW

The measurement system is based on a conducted test method.

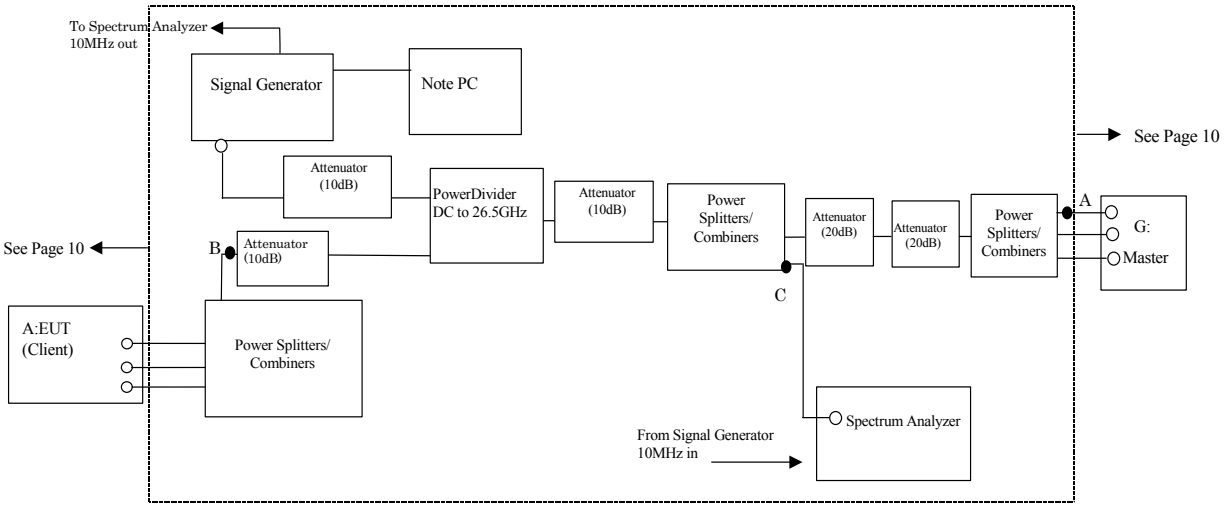
The software selects waveform parameters from within the bounds of the signal type on a random basis using uniform distribution. The short pulse types 2, 3, and 4, the long pulse type 5, and the frequency hopping type 6 parameters are randomized at run-time.

The signal monitoring equipment consists of a spectrum analyzer with the capacity to display 8192 bins on the horizontal axis. A time-domain resolution of 2 msec/bin is achievable with a 16 second sweep time, meeting the 10 seconds short pulse reporting criteria. The aggregate ON time is calculated by multiplying the number of bins above a threshold during a particular observation period by the dwell time per bin, with the analyzer set to peak detection. A time-domain resolution of 3 msec/bin is achievable with a 24 second sweep time, meeting the 22 second long pulse reporting criteria and allowing a minimum of 10 seconds after the end of the long pulse waveform.

FREQUENCY HOPPING RADAR WAVEFORM GENERATING SUBSYSTEM

The first 100 frequencies are selected out of the hopping sequence of the randomized 475 hop frequencies.
Only a *Burst* that has the frequency falling within the receiver bandwidth of the tested U-NII device is selected among those frequencies. (Frequency-domain simulation). The radar waveform generated at the start time of the selected *Burst* (Time-domain simulation) is download to the Signal Generator.
If all of the randomly selected 100 frequencies do not fall within the receiver bandwidth of the U-NII device, the radar waveform is not used for the test.

CONDUCTED METHODS SYSTEM BLOCK DIAGRAM



MEASUREMENT SYSTEM FREQUENCY REFERENCE

Lock the signal generator and the spectrum analyzer to the same reference sources as follows: Connect the 10MHz OUT on the signal generator to the 10MHz IN on the spectrum analyzer and set the spectrum analyzer 10MHz In to On.

SYSTEM CALIBRATION

Step 1: Set the system as shown in Figure 3 of FCC 06-96 7.2.1.

Step 2: Adjust each attenuator to fulfill the following three conditions:
- WLAN can be communicated, and
- Radar detection threshold level is bigger than Client Device traffic level on the spectrum analyzer, and
- Master Device traffic level is not displayed on the spectrum analyzer.

Step 3: Terminate 50 ohm at B and C points, and connect the spectrum analyzer to the point A. (See the figure on page 12)
At the point A, adjust the signal generator and spectrum analyzer to the center frequency of the channel to be measured.
Download the applicable radar waveforms to the signal generator. Select the radar waveform, trigger a burst manually and measure the amplitude on the spectrum analyzer. Read just the amplitude of the signal generator as required so that the peak level of the waveform is at a displayed level equal to the required or desired interference detection threshold.
Separate signal generator amplitude settings are determined as required for each radar type.

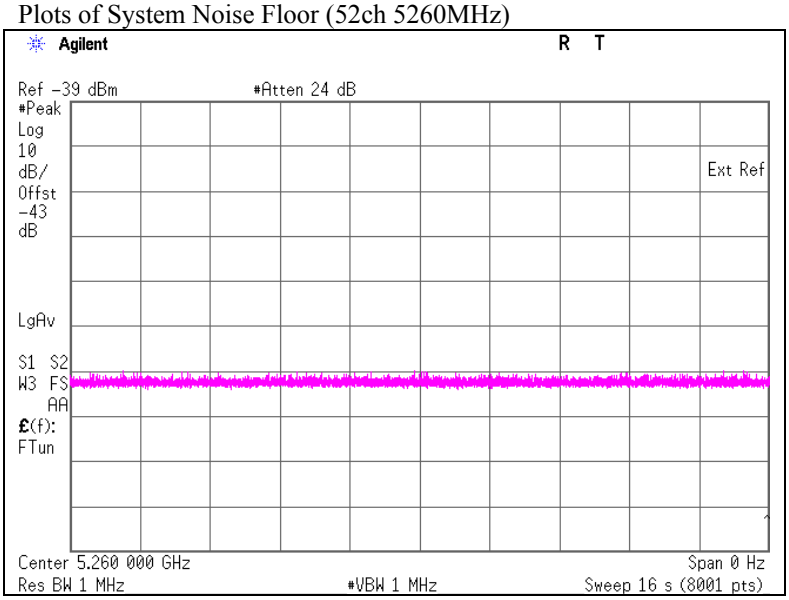
Step 4: Without changing any of the instrument settings, restore the system setting to Step 2 and adjust the Reference Level Offset of the spectrum analyzer to the level at Step 3.

By taking the above steps 1 to 4, the spectrum analyzer displays the level of the signal generator as received at the antenna ports of the Master Device.

See Clause 5.4 for Plots of Noise, Radar Waveforms, and WLAN signals.

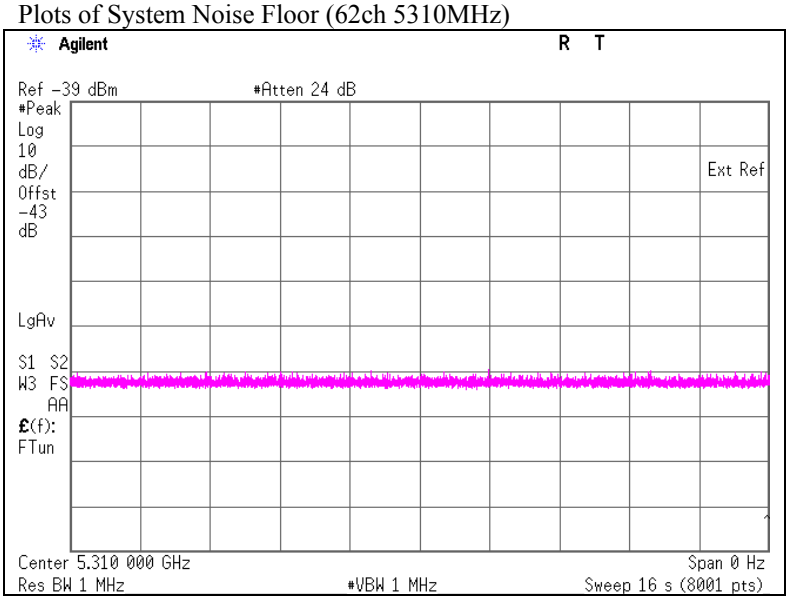
5.4 Plots of Noise, Radar Waveforms, and WLAN signals

Plots of System Noise Floor (52ch 5260MHz)



It was confirmed that the EUT did not transmit before having received appropriate control signals from a Master Device.

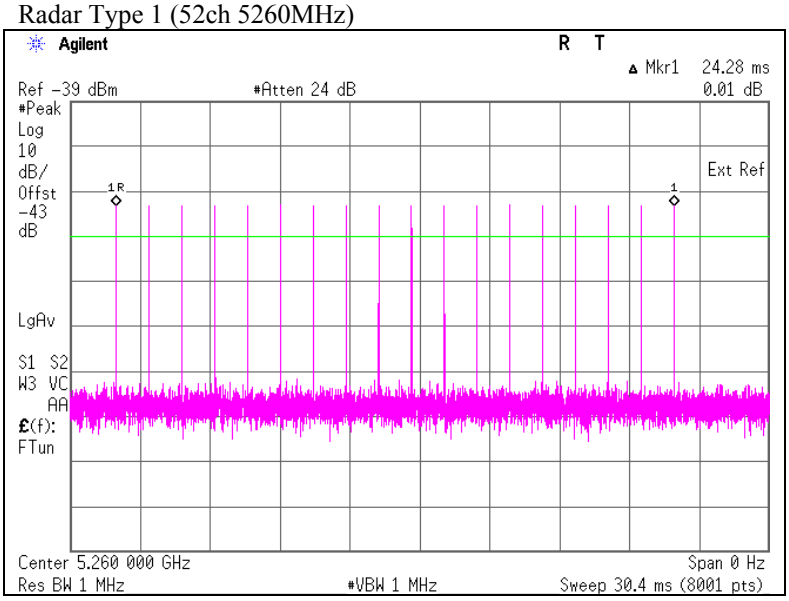
Plots of System Noise Floor (62ch 5310MHz)



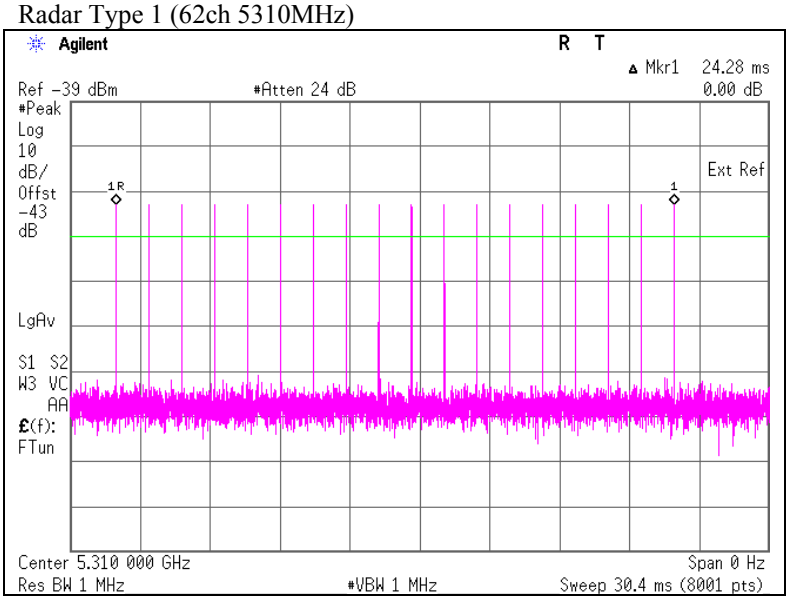
It was confirmed that the EUT did not transmit before having received appropriate control signals from a Master Device.

Plots of Radar Waveforms

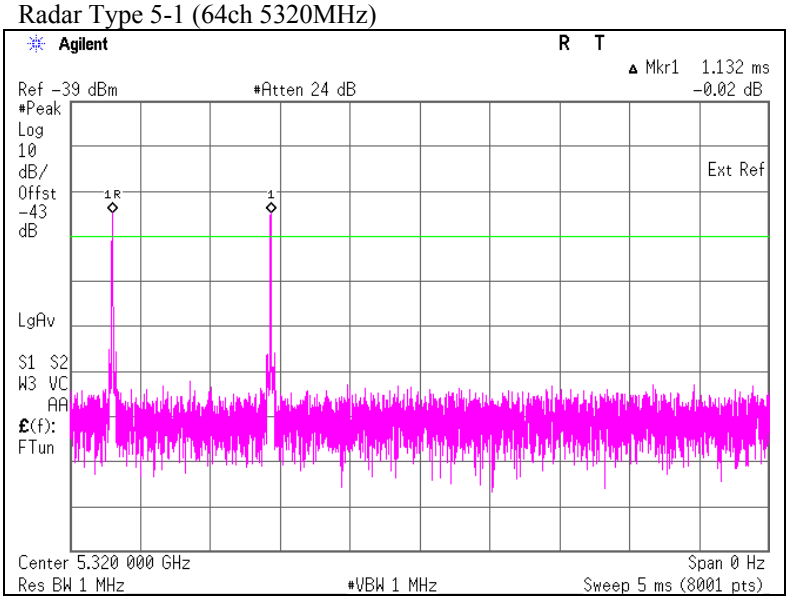
Radar Type 1 (52ch 5260MHz)



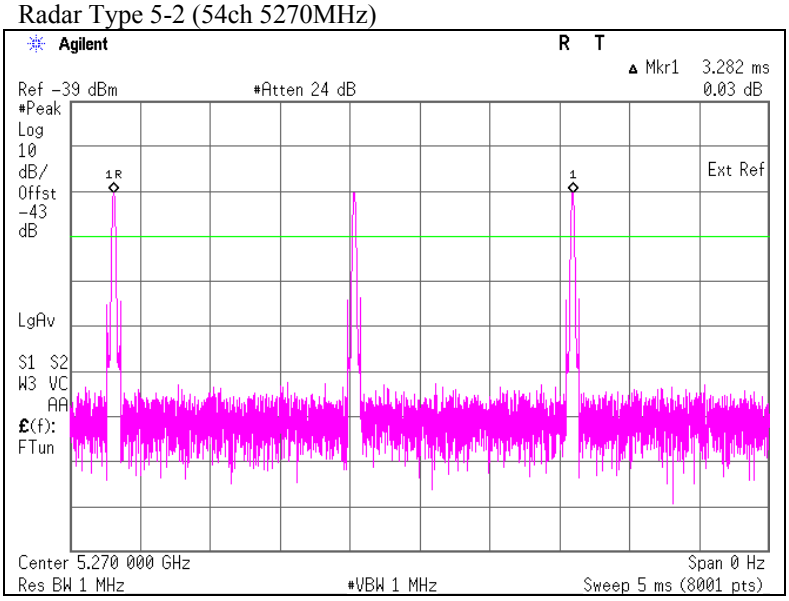
Radar Type 1 (62ch 5310MHz)



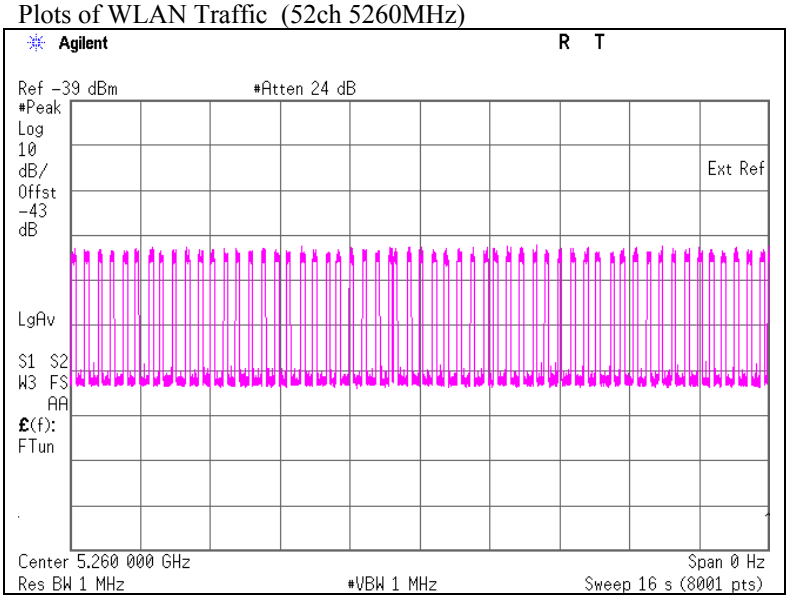
Radar Type 5-1 (64ch 5320MHz)



Radar Type 5-2 (54ch 5270MHz)



Plots of WLAN Traffic (52ch 5260MHz)



SECTION 6: In-Service Monitoring for Channel Move Time, Channel Closing Transmission Time

6.1 Operating environment

Test place : No.11 measurement room
Temperature : 23 deg.C.
Humidity : 46 %

6.2 Test Procedure

Stream the MPEG test file from the Master Device to the Client Device on the test Channel for the entire period of the test.
The Radar Waveform generator sends a Burst of pulses for one of the Short Pulse Radar Types 1-4 at levels defined , on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors.
Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel for duration greater than 10 seconds.

6.3 Test data

11n 20HT

Test Item	Unit	Measurement Time	Limit	Results
Channel Move Time *1)	[sec]	1.260	10.000	Pass
Channel Closing Transmission Time *2)	[msec]	12	60	Pass

*1) Channel Move Time is calculated as follows:
(Channel Move Time) = (End of Transmission) - (End of Burst) = 1.986 – 0.726

*2) Channel Closing Transmission Time is calculated from (End of Burst + 200msec) to (End of Burst + 10sec)
(Channel Closing Transmission Time) = (Number of analyzer bins showing transmission) * (dwell time per bin)
= 6 * 2(msec)

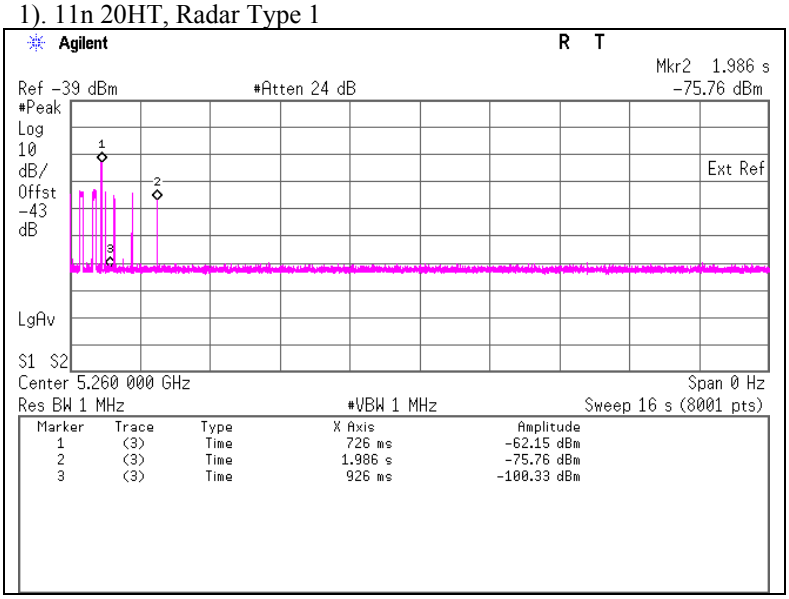
11n 40HT

Test Item	Unit	Measurement Time	Limit	Results
Channel Move Time *1)	[sec]	1.250	10.000	Pass
Channel Closing Transmission Time *2)	[msec]	12	60	Pass

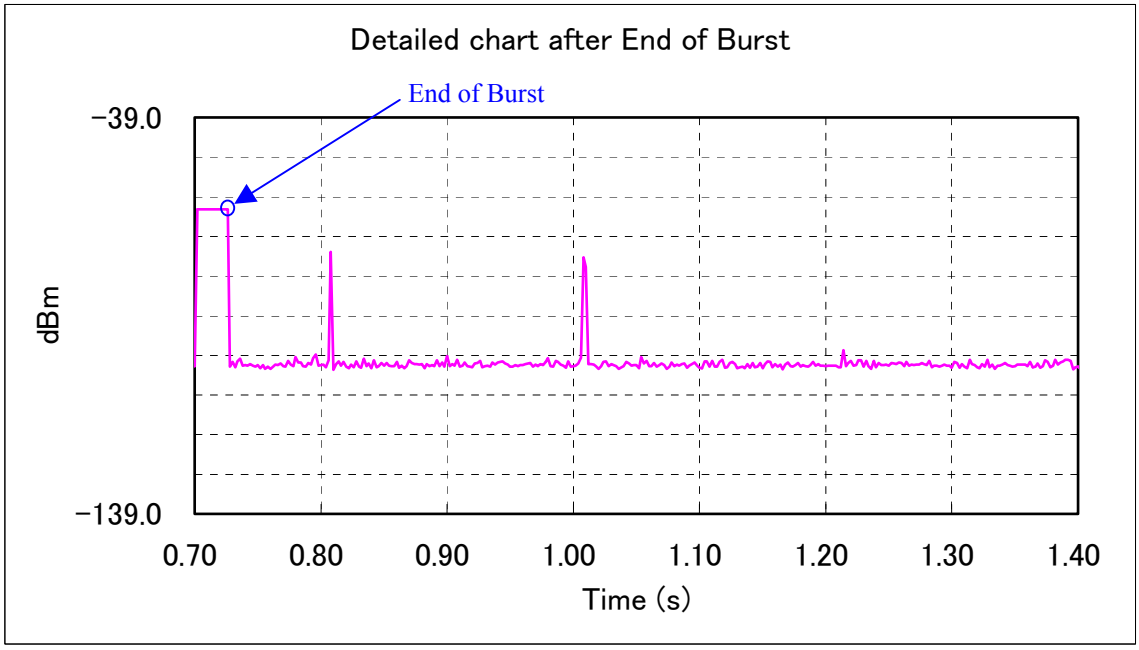
*1) Channel Move Time is calculated as follows:
(Channel Move Time) = (End of Transmission) - (End of Burst) = 2.730 – 1.480

*2) Channel Closing Transmission Time is calculated from (End of Burst + 200msec) to (End of Burst + 10sec)
(Channel Closing Transmission Time) = (Number of analyzer bins showing transmission) * (dwell time per bin)
= 6 * 2(msec)

1). 11n 20HT, Radar Type 1

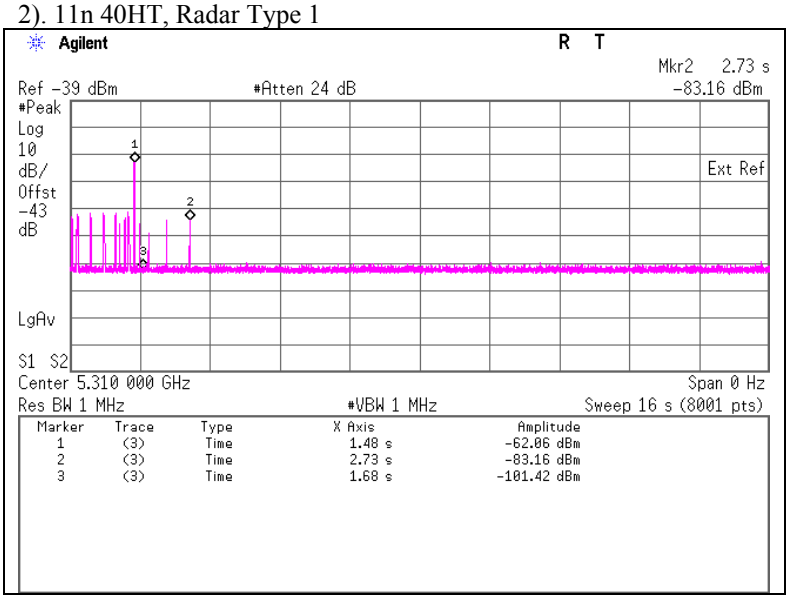


Marker 1 : End of Burst : 726 ms
Marker 2 : End of Transmission : 1986 ms

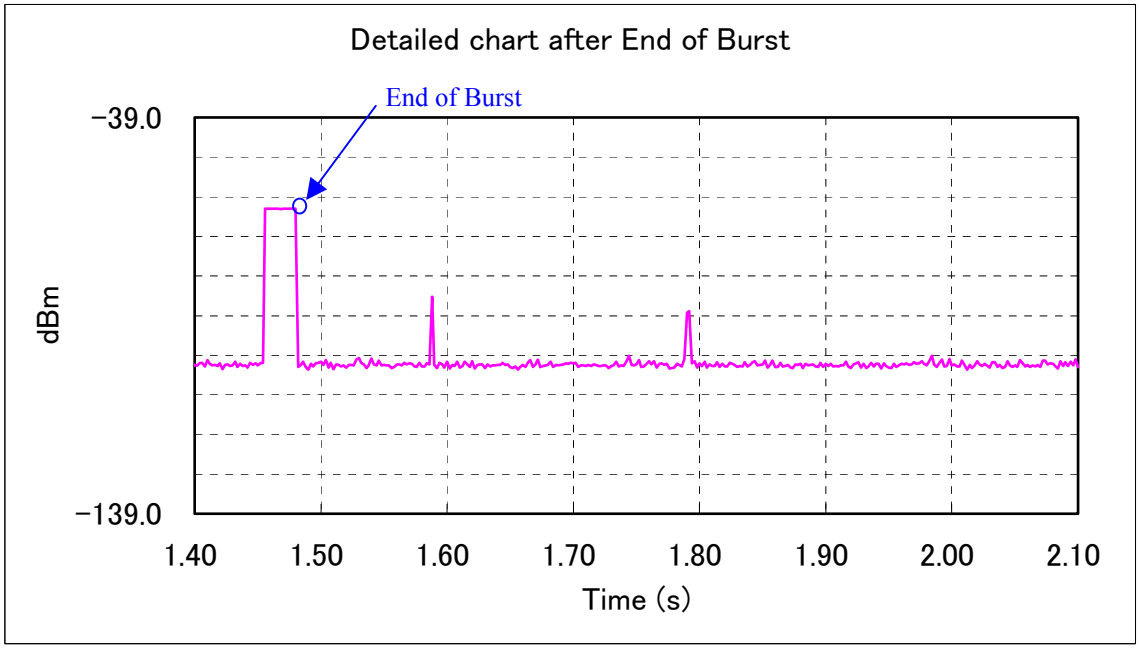


UL Japan, Inc.
Head Office EMC Lab.
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116
Facsimile : +81 596 24 8124

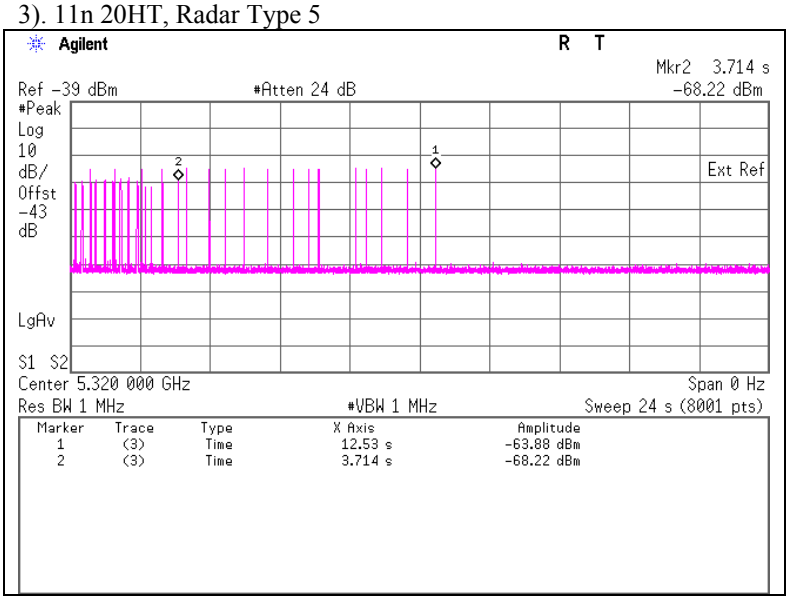
2). 11n 40HT, Radar Type 1



Marker 1 : End of Burst : 1480 ms
Marker 2 : End of Transmission : 2730 ms

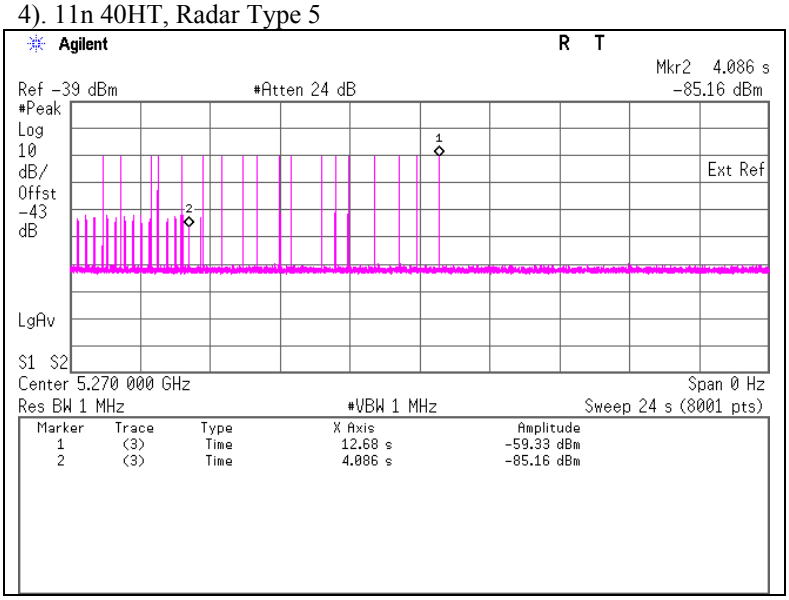


3). 11n 20HT, Radar Type 5



Marker 1 : End of Burst : 12530 ms
Marker 2 : End of Transmission : 3714 ms

4). 11n 40HT, Radar Type 5



Marker 1 : End of Burst : 12680 ms
Marker 2 : End of Transmission : 4086 ms

6.4 Test result

Test result: Pass

Date : April 7, 2009 Test engineer : Takahiro Hatakeda

SECTION 7: In-Service Monitoring for Non-Occupancy Period

7.1 Operating environment

Test place : No.11 measurement room
Temperature : 23 deg.C.
Humidity : 46 %

7.2 Test Procedure

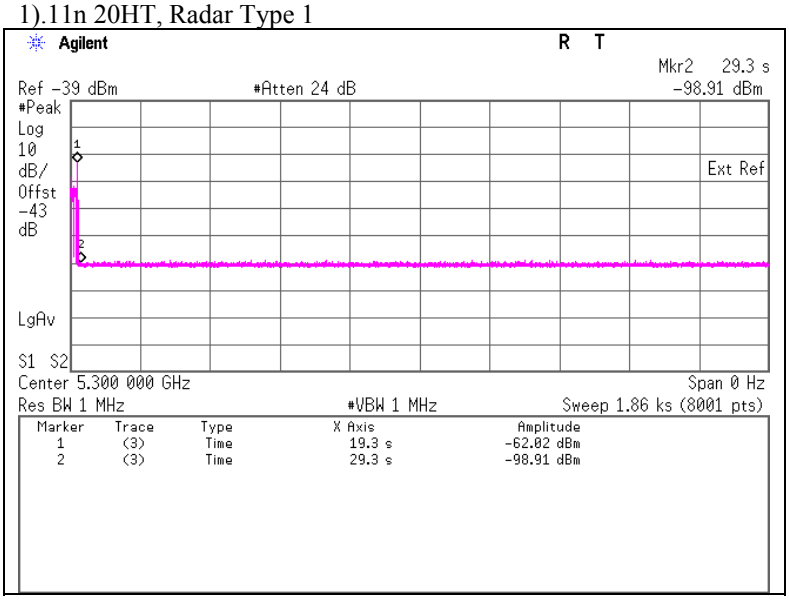
The following two tests are performed:

1).Stream the MPEG test file from the Master Device to the Client Device on the test Channel for the entire period of the test.
The Radar Waveform generator sends a Burst of pulses for one of the Radar Types 1-6 at levels defined on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors.
Observe the transmissions of the EUT after the Channel Move Time on the Operating Channel for duration greater than 30 minutes.

2). Stream the MPEG test file from the Master Device to the Client Device on the test Channel for the entire period of the test.
Observe the transmissions of the EUT on the Operating Channel for duration greater than 30 minutes after the Master Device is shut off.

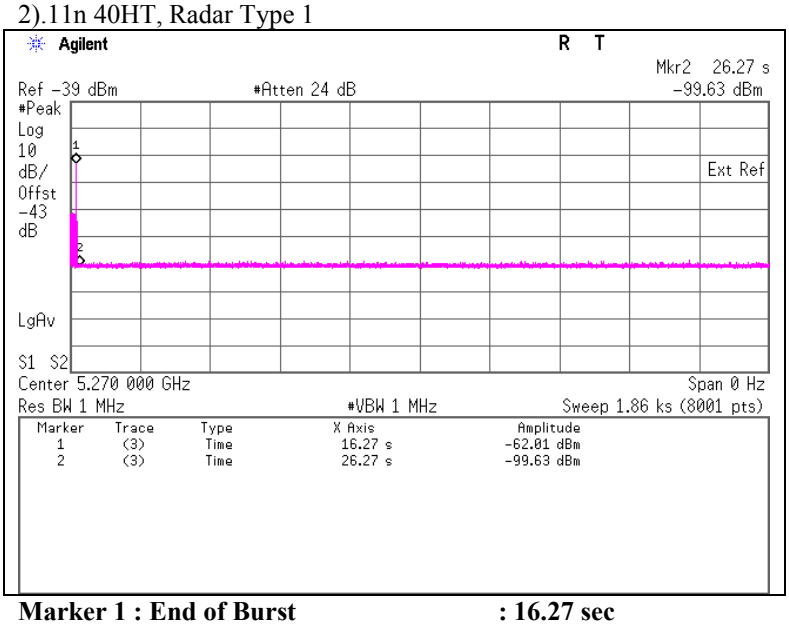
7.3 Test data

1).11n 20HT, Radar Type 1



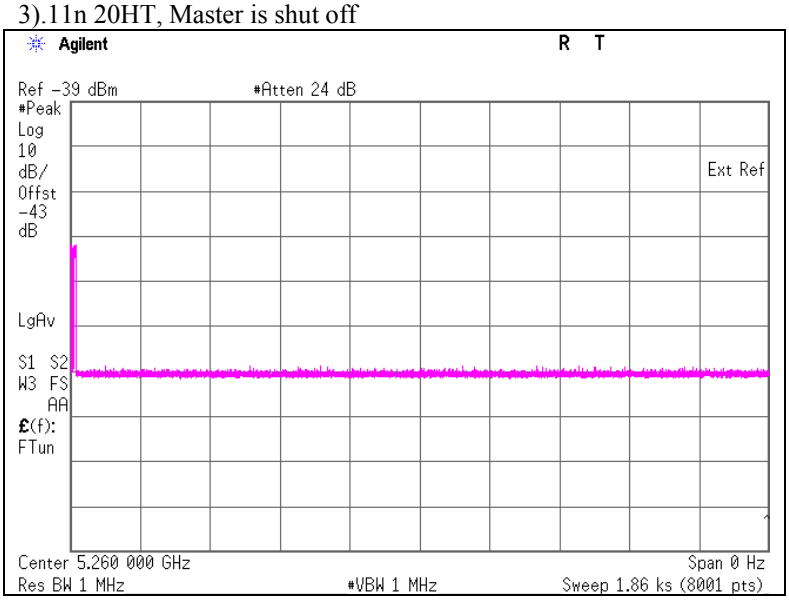
Marker 1 : End of Burst : 19.30 sec
Marker 2 : End of Burst +10sec : 29.30 sec

2).11n 40HT, Radar Type 1

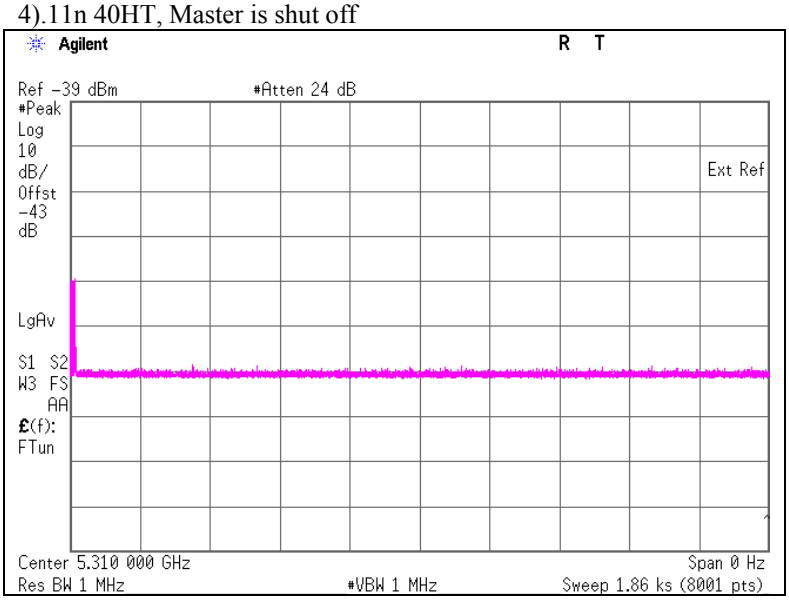


Marker 1 : End of Burst : 16.27 sec
Marker 2 : End of Burst +10sec : 26.27 sec

3).11n 20HT, Master is shut off



4).11n 40HT, Master is shut off



7.4 Test result

Test result: Pass

Date : April 7, 2009 Test engineer : Takahiro Hatakeda